

**Search Notes**

Application/Control No.

09/837,222

Examiner

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Applicant(s)/Patent under  
Reexamination

LIN, WEI

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	229-238, 395.2- 395.4	4/18/2006	TP
370	465-469	4/18/2006	TP
Updated	search	10/4/2006	TP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search history printout		10/4/2006	TP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPT,JPAB,EPAB,DWPI) - see text search only history printout.	4/18/2006	TP
eDAN-Relation Application 09/837,381; PALM-Inventor Name and Continuity Data checked.	10/4/2006	TP
EAST (USPT,JPAB,EPAB,FPRS,DWPI) - see text search only history printout.	10/4/2006	TP